

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/645,249	TAKAHASHI ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Justin Krause	3682	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0066658	06-2002	Agetsuma, Nobuaki	200/61.54
*	B	US-2002/0033321	03-2002	Miyako et al.	200/61.54
*	C	US-6,349,616	02-2002	Onodera et al.	74/552
*	D	US-2003/0061896	04-2003	Takai et al.	74/473.12
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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